



Docket No.: 58604-029

PATENT

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re Application of : Customer Number: 20277  
Shigeo MURAKAMI : Confirmation Number: 7075  
Serial No.: 10/615,294 : Group Art Unit: 2621  
Filed: July 09, 2003 : Examiner: Unknown  
For: PRINT QUALITY MEASURING METHOD AND PRINT QUALITY MEASURING APPARATUS

**INFORMATION DISCLOSURE STATEMENT**

Mail Stop IDS  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /V.H./

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

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**Date: October 30, 2003**



SHEET 1 OF 1

<b>INFORMATION DISCLOSURE CITATION IN AN APPLICATION</b>  <b>(PTO-1449)</b>				ATTY. DOCKET NO. <b>58604-029</b>	SERIAL NO. <b>10/615,294</b>	
				APPLICANT <b>Shigeo MURAKAMI</b>		
				FILING DATE <b>July 09, 2003</b>	GROUP <b>2621</b>	
<b>U.S. PATENT DOCUMENTS</b>						
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code <sub>2</sub> ( <i>if known</i> )	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document		Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
	B1	US 6,382,101	05/07/2002	Richards		
		US 5,724,437	03/03/1998	Bucher et al.		
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<b>FOREIGN PATENT DOCUMENTS</b>						
EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes-Number & -Kind Codes ( <i>if known</i> )	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation
		JP 4-303660	10/27/1992	MAN ROLAND DRUCKMAS AG		Yes <input type="checkbox"/> No <input type="checkbox"/>
		JP 8-261829	10/11/1996	TOPPAN PRINTING CO LTD		X <input type="checkbox"/>
		JP 10-305562	11/17/1998	TOPPAN PRINTING CO LTD		X <input type="checkbox"/>
		JP P2001-353852A	12/25/2001	DAINIPPON SCREEN MFG CO LTD		X <input type="checkbox"/>
		JP 11-320838	11/24/1999	MITSUBISHI HEAVY IND LTD		X <input type="checkbox"/>
		JP 9-193361	07/29/1997	HEIDELBERGER DRUCKMAS AG		X <input type="checkbox"/>
<b>OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)</b>						
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.				
EXAMINER <b>/Vu Hang/</b>			DATE CONSIDERED <b>02/01/2010</b>			

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /V.H./